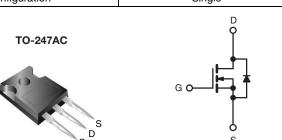


Vishay Siliconix

### **Power MOSFET**

PRODUCT SUMMARY				
V <sub>DS</sub> (V)	500			
R <sub>DS(on)</sub> (Ω)	V <sub>GS</sub> = 10 V	V <sub>GS</sub> = 10 V 0.15		
Q <sub>g</sub> (Max.) (nC)	210			
Q <sub>gs</sub> (nC)	58			
Q <sub>gd</sub> (nC)	100			
Configuration	Sing	Single		



#### N-Channel MOSFET

### **FEATURES**

• Super Fast Body Diode Eliminates the Need for External Diodes in ZVS Applications



• Lower Gate Charge Results in Simpler Drive RoHS Requirements

- Enhanced dV/dt Capabilities Offer Improved Ruggedness
- Higher Gate Voltage Threshold Offers Improved Noise Immunity
- Compliant to RoHS Directive 2002/95/EC

#### **APPLICATIONS**

- Zero Voltage Switching SMPS
- Telecom and Server Power Supplies
- Uninterruptible Power Supplies
- Motor Control Applications

ORDERING INFORMATION		
Package	TO-247AC	
Lead (Pb)-free	IRFP31N50LPbF	
Lead (FD)-life	SiHFP31N50L-E3	
SnPb	IRFP31N50L	
SIFD	SiHFP31N50L	

ABSOLUTE MAXIMUM RATINGS (T <sub>C</sub> = 25 °C, unless otherwise noted)					
PARAMETER			SYMBOL	LIMIT	UNIT
Drain-Source Voltage			V <sub>DS</sub>	500	V
Gate-Source Voltage			$V_{GS}$	± 30	7 °
Continuous Drain Current	V <sub>GS</sub> at 10 V	$T_{\rm C} = 25  ^{\circ}{\rm C}$ $T_{\rm C} = 100  ^{\circ}{\rm C}$		31	
Continuous Drain Current	VGS at 10 V	T <sub>C</sub> = 100 °C	I <sub>D</sub>	20	A
Pulsed Drain Current <sup>a</sup>			I <sub>DM</sub>	124	
Linear Derating Factor				3.7	W/°C
Single Pulse Avalanche Energy <sup>b</sup>			E <sub>AS</sub>	460	mJ
Repetitive Avalanche Currenta			I <sub>AR</sub>	31	А
Repetitive Avalanche Energy <sup>a</sup>			E <sub>AR</sub>	46	mJ
Maximum Power Dissipation	T <sub>C</sub> =	25 °C	$P_{D}$	460	W
Peak Diode Recovery dV/dt <sup>c</sup>			dV/dt	19	V/ns
Operating Junction and Storage Temperature Range			T <sub>J</sub> , T <sub>stg</sub>	- 55 to + 150	°C
Soldering Recommendations (Peak Temperature) for 10 s				300 <sup>d</sup>	7
Mounting Torque 6-32 or M3 screw			10	lbf ⋅ in	
		IVIO SCIEW		1.1	N⋅m

- a. Repetitive rating; pulse width limited by maximum junction temperature (see fig. 11).
- b. Starting  $T_J$  = 25 °C, L = 1 mH,  $R_g$  = 25  $\Omega$ ,  $I_{AS}$  = 31 A (see fig. 12).
- c.  $I_{SD} \leq 31$  A,  $dI/dt \leq 422$  A/µs,  $V_{DD} \leq V_{DS},\, T_{J} \leq 150$  °C.
- d. 1.6 mm from case.

<sup>\*</sup> Pb containing terminations are not RoHS compliant, exemptions may apply

# IRFP31N50L, SiHFP31N50L

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THERMAL RESISTANCE RATINGS				
PARAMETER	SYMBOL	TYP.	MAX.	UNIT
Maximum Junction-to-Ambient	R <sub>thJA</sub>	-	40	
Case-to-Sink, Flat, Greased Surface	R <sub>thCS</sub>	0.24	-	°C/W
Maximum Junction-to-Case (Drain)	R <sub>thJC</sub>	-	0.26	

PARAMETER	SYMBOL	TES	T CONDITIONS	MIN.	TYP.	MAX.	UNIT
Static							
Drain-Source Breakdown Voltage	V <sub>DS</sub>	$V_{GS} = 0 \text{ V}, I_D = 250 \mu\text{A}$		500	-	-	V
V <sub>DS</sub> Temperature Coefficient	$\Delta V_{DS}/T_{J}$	Referenc	e to 25 °C, I <sub>D</sub> = 1 mA	-	0.28	-	V/°C
Gate-Source Threshold Voltage	V <sub>GS(th)</sub>	V <sub>DS</sub> =	· V <sub>GS</sub> , I <sub>D</sub> = 250 μA	3.0	-	5.0	V
Gate-Source Leakage	I <sub>GSS</sub>	,	V <sub>GS</sub> = ± 30 V	-	-	± 100	nA
Zana Onto Walliana Buria O annot		V <sub>DS</sub> =	500 V, V <sub>GS</sub> = 0 V	-	-	50	μΑ
Zero Gate Voltage Drain Current	I <sub>DSS</sub>	V <sub>DS</sub> = 400 V	, V <sub>GS</sub> = 0 V, T <sub>J</sub> = 125 °C	-	-	2.0	mA
Drain-Source On-State Resistance	R <sub>DS(on)</sub>	V <sub>GS</sub> = 10 V	I <sub>D</sub> = 19 A <sup>b</sup>	-	0.15	0.18	Ω
Forward Transconductance	9 <sub>fs</sub>	V <sub>DS</sub> =	= 50 V, I <sub>D</sub> = 19 A <sup>b</sup>	15	-	-	S
Dynamic							
Input Capacitance	C <sub>iss</sub>		V <sub>GS</sub> = 0 V,	-	5000	-	
Output Capacitance	C <sub>oss</sub>		$V_{DS} = 25 \text{ V},$	-	553	-	
Reverse Transfer Capacitance	C <sub>rss</sub>	f = 1.	0 MHz, see fig. 5	-	59	-	
Outrat Constitutes	0		V <sub>DS</sub> = 1.0 V , f = 1.0 MHz	-	6630	-	pF
Output Capacitance	$C_{oss}$	.,	V <sub>DS</sub> = 400 V , f = 1.0 MHz	-	155	-	
Effective Output Capacitance	C <sub>oss</sub> eff.	$V_{GS} = 0 V$	V <sub>DS</sub> = 0 V to 400 V <sup>c</sup>	-	276	-	
Effective Output Capacitance	Coss eff. (ER)	_		-	200	-	
Total Gate Charge	Qg		I <sub>D</sub> = 31 A, V <sub>DS</sub> = 400 V, see fig. 7 and 13 <sup>b</sup>	-	-	210	1
Gate-Source Charge	Q <sub>gs</sub>	V <sub>GS</sub> = 10 V		-	-	58	nC
Gate-Drain Charge	Q <sub>gd</sub>	see lig. 7 and 13		-	-	100	
Internal Gate Resistance	Rg	f = 1	MHz, open drain	-	1.1	-	Ω
Turn-On Delay Time	t <sub>d(on)</sub>			-	28	-	
Rise Time	t <sub>r</sub>	V <sub>DD</sub> =	: 250 V, I <sub>D</sub> = 31 A,	-	115	-	ns
Turn-Off Delay Time	t <sub>d(off)</sub>	$R_g = 4$	4.3 Ω, see fig. 10 <sup>b</sup>	-	54	-	
Fall Time	t <sub>f</sub>			-	53	-	
<b>Drain-Source Body Diode Characteristic</b>	s				I.	•	
Continuous Source-Drain Diode Current	I <sub>S</sub>	MOSFET sym showing the		-	-	31	A
Pulsed Diode Forward Current <sup>a</sup>	I <sub>SM</sub>	integral revers p - n junction		-	-	124	
Body Diode Voltage	V <sub>SD</sub>	T <sub>J</sub> = 25 °C	$I_{S}$ , $I_{S} = 31$ A, $V_{GS} = 0$ V <sup>b</sup>	-	-	1.5	V
Pady Diada Payaraa Passyary Tim-	+	T <sub>J</sub> =	25 °C, I <sub>F</sub> = 31 A	-	170	250	
Body Diode Reverse Recovery Time	t <sub>rr</sub>	T <sub>J</sub> = 125 °C, dl/dt = 100 A/μs <sup>b</sup>		-	220	330	ns
Rady Diada Dayaraa Daaaaa Obaa	0	T <sub>J</sub> = 25 °C	s, I <sub>S</sub> = 31 A, V <sub>GS</sub> = 0 V <sup>b</sup>	-	570	860	nC
Body Diode Reverse Recovery Charge	$Q_{rr}$	T <sub>J</sub> = 125	°C, dl/dt = 100 A/µsb	-	1.2	1.8	μC
Reverse Recovery Current	I <sub>RRM</sub>	T <sub>J</sub> = 25 °C		-	7.9	12	Α
Forward Turn-On Time	t <sub>on</sub>	Intrinsic turn-on time is negligible (turn-		on is do	minated b	y L <sub>S</sub> and	L <sub>D</sub> )

- Repetitive rating; pulse width limited by maximum junction temperature (see fig. 11). Pulse width  $\leq 300~\mu s$ ; duty cycle  $\leq 2~\%$ . Coss eff. is a fixed capacitance that gives the same charging time as  $C_{oss}$  while  $V_{DS}$  is rising from 0 % to 80 %  $V_{DS}$ .  $C_{oss}$  eff. (ER) is a fixed capacitance that stores the same energy as  $C_{oss}$  while  $V_{DS}$  is rising from 0 % to 80 %  $V_{DS}$ .



### TYPICAL CHARACTERISTICS (25 °C, unless otherwise noted)

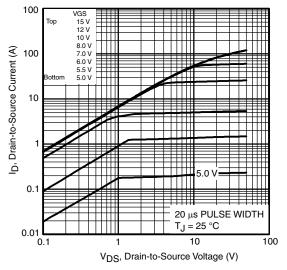


Fig. 1 - Typical Output Characteristics

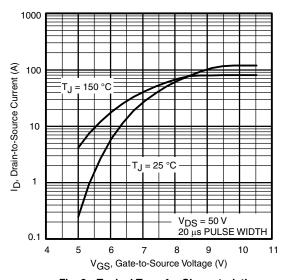


Fig. 3 - Typical Transfer Characteristics

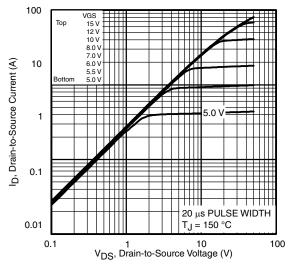


Fig. 2 - Typical Output Characteristics

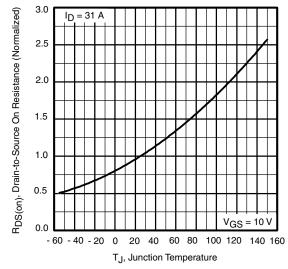


Fig. 4 - Normalized On-Resistance vs. Temperature

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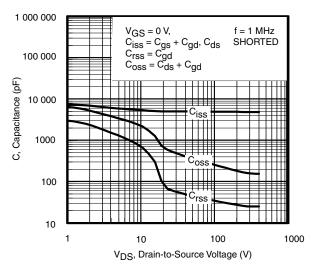


Fig. 5 - Typical Capacitance vs. Drain-to-Source Voltage

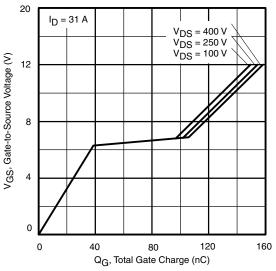


Fig. 7 - Typical Gate Charge vs. Gate-to-Source Voltage

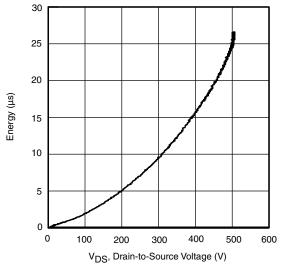


Fig. 6 - Output Capacitance Stored Energy vs. V<sub>DS</sub>

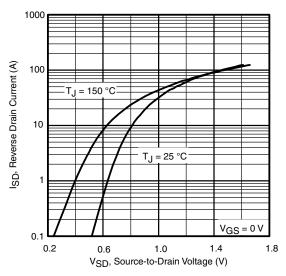


Fig. 8 - Typical Source Drain Diode Forward Voltage



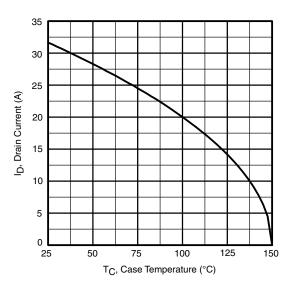


Fig. 9 - Maximum Drain Current vs. Case Temperature

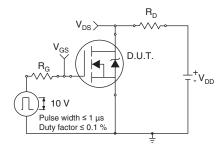


Fig. 10a - Switching Time Test Circuit

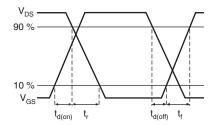


Fig. 10b - Switching Time Waveforms

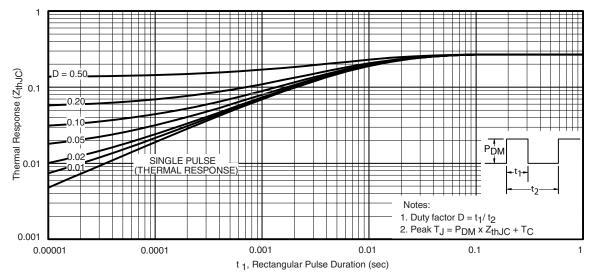


Fig. 11 - Maximum Effective Transient Thermal Impedance, Junction-to-Case

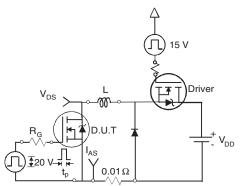


Fig. 12a - Unclamped Inductive Test Circuit

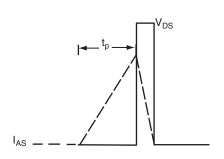


Fig. 12b - Unclamped Inductive Waveforms

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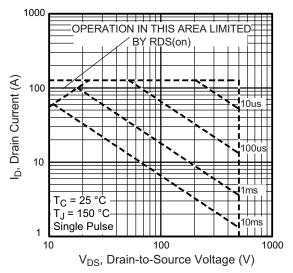
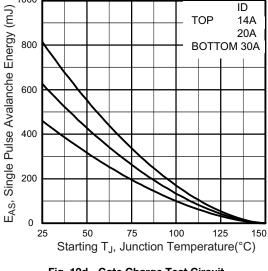


Fig. 12c - Maximum Avalanche Energy vs. Drain Current



1000

Fig. 12d - Gate Charge Test Circuit

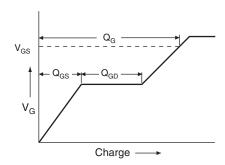


Fig. 13a - Maximum Safe Operating Area

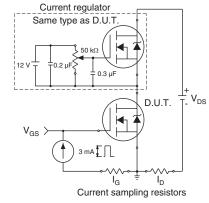
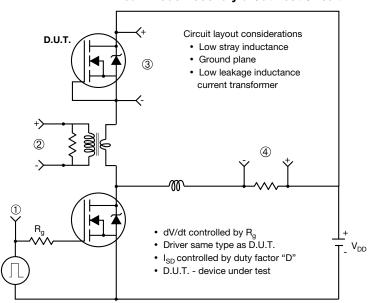


Fig. 13b - Basic Gate Charge Waveform



#### Peak Diode Recovery dV/dt Test Circuit



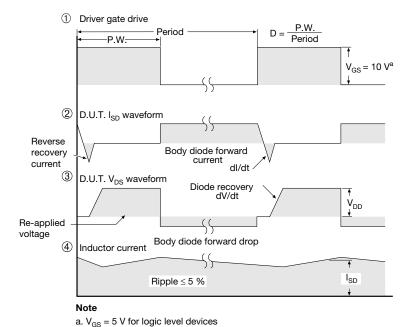


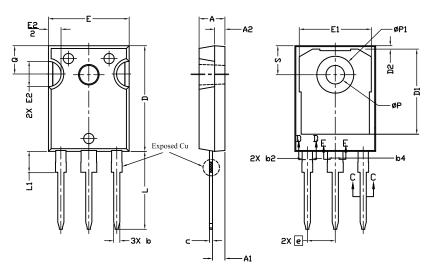
Fig. 14 - For N-Channel

Vishay Siliconix maintains worldwide manufacturing capability. Products may be manufactured at one of several qualified locations. Reliability data for Silicon Technology and Package Reliability represent a composite of all qualified locations. For related documents such as package/tape drawings, part marking, and reliability data, see www.vishay.com/ppg?91220.

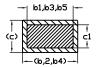


# **TO-247AC (High Voltage)**

### **VERSION 1: FACILITY CODE = 9**







Section C--C,D--D,E--E

	MILLIN	IETERS	
DIM.	MIN.	MAX.	NOTES
Α	4.83	5.21	
A1	2.29	2.55	
A2	1.50	2.49	
b	1.12	1.33	
b1	1.12	1.28	
b2	1.91	2.39	6
b3	1.91	2.34	
b4	2.87	3.22	6, 8
b5	2.87	3.18	
С	0.55	0.69	6
c1	0.55	0.65	
D	20.40	20.70	4

	MILLIM		
DIM.	MIN.	MAX.	NOTES
D1	16.25	16.85	5
D2	0.56	0.76	
E	15.50	15.87	4
E1	13.46	14.16	5
E2	4.52	5.49	3
е	5.44	BSC	
L	14.90	15.40	
L1	3.96	4.16	6
ØΡ	3.56	3.65	7
Ø P1	7.19 ref.		
Q	5.31	5.69	
S	5.54	5.74	

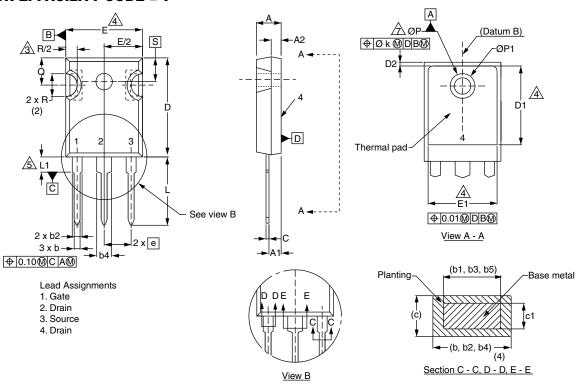
#### Notes

- (1) Package reference: JEDEC® TO247, variation AC
- (2) All dimensions are in mm
- (3) Slot required, notch may be rounded
- (4) Dimension D and E do not include mold flash. Mold flash shall not exceed 0.127 mm per side. These dimensions are measured at the outermost extremes of the plastic body
- (5) Thermal pad contour optional with dimensions D1 and E1
- (6) Lead finish uncontrolled in L1
- (7) Ø P to have a maximum draft angle of 1.5° to the top of the part with a maximum hole diameter of 3.91 mm
- (8) Dimension b2 and b4 does not include dambar protrusion. Allowable dambar protrusion shall be 0.1 mm total in excess of b2 and b4 dimension at maximum material condition

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### **VERSION 2: FACILITY CODE = Y**



	MILLIM		
DIM.	MIN.	MAX.	NOTES
Α	4.58	5.31	
A1	2.21	2.59	
A2	1.17	2.49	
b	0.99	1.40	
b1	0.99	1.35	
b2	1.53	2.39	
b3	1.65	2.37	
b4	2.42	3.43	
b5	2.59	3.38	
С	0.38	0.86	
c1	0.38	0.76	
D	19.71	20.82	
D1	13.08	-	

	MILLIN		
DIM.	MIN.	MAX.	NOTES
D2	0.51	1.30	
E	15.29	15.87	
E1	13.72	-	
е	5.46	BSC	
Øk	0.2	254	
L	14.20	16.25	
L1	3.71	4.29	
ØР	3.51	3.66	
Ø P1	-	7.39	
Q	5.31	5.69	
R	4.52	5.49	
S	5.51 BSC		

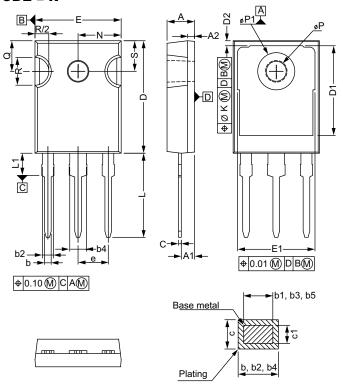
#### **Notes**

- (1) Dimensioning and tolerancing per ASME Y14.5M-1994
- (2) Contour of slot optional
- (3) Dimension D and E do not include mold flash. Mold flash shall not exceed 0.127 mm (0.005") per side. These dimensions are measured at the outermost extremes of the plastic body
- (4) Thermal pad contour optional with dimensions D1 and E1
- (5) Lead finish uncontrolled in L1
- (6) Ø P to have a maximum draft angle of 1.5 to the top of the part with a maximum hole diameter of 3.91 mm (0.154")
- (7) Outline conforms to JEDEC outline TO-247 with exception of dimension c

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### **VERSION 3: FACILITY CODE = N**



	MILLIMETERS		
DIM.	MIN.	MAX.	
Α	4.65	5.31	
A1	2.21	2.59	
A2	1.17	1.37	
b	0.99	1.40	
b1	0.99	1.35	
b2	1.65	2.39	
b3	1.65	2.34	
b4	2.59	3.43	
b5	2.59	3.38	
С	0.38	0.89	
c1	0.38	0.84	
D	19.71	20.70	
D1	13.08	-	

	MILLIMETERS		
DIM.	MIN.	MAX.	
D2	0.51	1.35	
E	15.29	15.87	
E1	13.46	-	
е	5.46	BSC	
k	0.254		
L	14.20	16.10	
L1	3.71	4.29	
N	7.62	BSC	
Р	3.56	3.66	
P1	=	7.39	
Q	5.31	5.69	
R	4.52	5.49	
S	5.51 BSC		

ECN: E20-0545-Rev. F, 19-Oct-2020

DWG: 5971

#### **Notes**

- <sup>(1)</sup> Dimensioning and tolerancing per ASME Y14.5M-1994
- (2) Contour of slot optional
- (3) Dimension D and E do not include mold flash. Mold flash shall not exceed 0.127 mm (0.005") per side. These dimensions are measured at the outermost extremes of the plastic body
- (4) Thermal pad contour optional with dimensions D1 and E1
- (5) Lead finish uncontrolled in L1
- (6) Ø P to have a maximum draft angle of 1.5 to the top of the part with a maximum hole diameter of 3.91 mm (0.154")



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